

## CY7C1061DV33

# 16-Mbit (1M × 16) Static RAM

#### Features

- High speed □ t<sub>AA</sub> = 10 ns
- Low active power □ I<sub>CC</sub> = 175 mA at 100 MHz
- Low CMOS standby power □ I<sub>SB2</sub> = 25 mA
- Operating voltages of 3.3 ± 0.3 V
- 2.0 V data retention
- Automatic power down when deselected
- TTL compatible inputs and outputs
- Easy memory expansion with CE<sub>1</sub> and CE<sub>2</sub> features
- Available in Pb-free 54-pin TSOP II and 48-ball VFBGA packages
- Offered in single CE and dual CE options

#### **Functional Description**

The CY7C1061DV33 is a high performance CMOS Static RAM organized as 1,048,576 words by 16 bits.

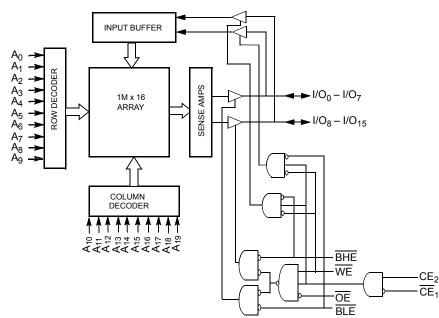
To write to the device, tak<u>e</u> Chip Enables ( $\overline{CE}_1$  LOW and  $CE_2$ <u>HIGH</u>) and Write Enable ( $\overline{WE}$ ) input LOW. If Byte Low Enable ( $\overline{BLE}$ ) is LOW, then data from I/O pins (I/O<sub>0</sub> through I/O<sub>7</sub>), is written into the location specified on the address pins (A<sub>0</sub> through A<sub>19</sub>). If Byte High Enable ( $\overline{BHE}$ ) is LOW, then data from I/O pins (I/O<sub>8</sub> through I/O<sub>15</sub>) is written into the location specified on the address pins (A<sub>0</sub> through A<sub>19</sub>).

To read from the device, take <u>Chip</u> Enables ( $\overline{CE}_1$  LOW and  $CE_2$  HIGH) <u>and</u> Output Enable ( $\overline{OE}$ ) LOW <u>while</u> forcing the Write Enable ( $\overline{WE}$ ) HIGH. If Byte Low Enable (BLE) is LOW, then data from the memory location specified <u>by the</u> address pins appears on I/O<sub>0</sub> to I/O<sub>7</sub>. If Byte High Enable (BHE) is LOW, then data from memory appears on I/O<sub>8</sub> to I/O<sub>15</sub>. See Truth Table on page 12 for a complete description of Read and Write modes.

The input or output pins (I/O<sub>0</sub> through I/O<sub>15</sub>) are <u>placed</u> in a high impedance state when the device is deselected ( $\underline{CE_1}$  HIGH/ $\underline{CE_2}$  LOW), the outputs are disabled (OE HIGH), the BHE and <u>BLE</u> are disabled (BHE, BL<u>E</u> HIGH), or during a write operation (CE<sub>1</sub> LOW, CE<sub>2</sub> HIGH, and WE LOW).

The CY7C1061DV33 is available in a 54-pin TSOP II package with center power and ground (revolutionary) pinout, and 48-ball VFBGA packages.

For a complete list of related documentation, click here.



#### Logic Block Diagram

**Cypress Semiconductor Corporation** Document Number: 38-05476 Rev. \*K



## CY7C1061DV33

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#### **Selection Guide**

| Description                  | -10 | Unit |
|------------------------------|-----|------|
| Maximum access time          | 10  | ns   |
| Maximum operating current    | 175 | mA   |
| Maximum CMOS standby current | 25  | mA   |

#### **Pin Configurations**

Figure 1. 48-ball VFBGA (8 × 9.5 × 1 mm) Dual Chip Enable (-BVXI) pinout (Top View) [1, 2]

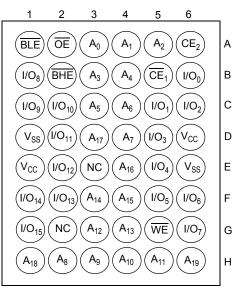
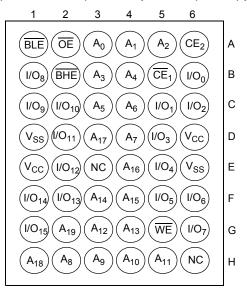


Figure 2. 48-ball VFBGA (8 × 9.5 × 1 mm) Dual Chip Enable (-BVJXI) pinout (Top View) [1, 2]



#### Notes

1. NC pins are not connected on the die.

2. In BVXI package, ball H6 is MSB address A19 and ball G2 is NC; in BVJXI package, ball H6 is NC and ball G2 is MSB address A19.





### Pin Configurations (continued)

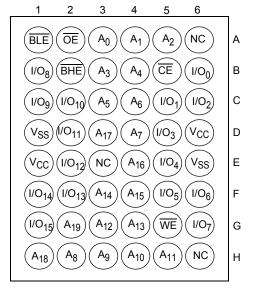
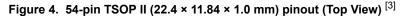


Figure 3. 48-ball VFBGA (8 × 9.5 × 1 mm) Single Chip Enable (-BV1XI) pinout (Top View) <sup>[3, 4]</sup>



|                       | = , 10                 |
|-----------------------|------------------------|
| I/O <sub>12</sub> □ 1 | 54 🔲 I/O <sub>11</sub> |
|                       | 53 🗆 V <sub>SS</sub>   |
| I/O <sub>13</sub> □ 3 | 52 🔲 I/O <sub>10</sub> |
| I/O <sub>14</sub> 🗖 4 | 51 🔲 I/O <sub>9</sub>  |
| V <sub>SS</sub> 5     | 50 🗌 V <sub>CC</sub>   |
| I/O <sub>15</sub> 🗖 6 | 49 🗌 I/O <sub>8</sub>  |
| A <sub>4</sub> 🗖 7    | 48 🗖 A <sub>5</sub>    |
| A3 🗖 8                | 47 🗖 A <sub>6</sub>    |
| A <sub>2</sub> 🗖 9    | 46 🗌 A <sub>7</sub>    |
| A <sub>1</sub> 10     | 45 🗆 A <sub>8</sub>    |
| A <sub>0</sub> 11     | 44 🗌 A <sub>9</sub>    |
| BHE 12                | 43 🗖 NC                |
| CE1 13                | 42 🗌 OE                |
| V <sub>CC</sub> □ 14  | 41 🗆 V <sub>SS</sub>   |
| WE 15                 | 40 🗌 NC                |
| CE <sub>2</sub> 16    | 39 🗌 BLE               |
| A <sub>19</sub> 🗖 17  | 38 🗖 A <sub>10</sub>   |
| A <sub>18</sub> 🗌 18  | 37 🗖 A <sub>11</sub>   |
| A <sub>17</sub> 19    | 36 🗌 A <sub>12</sub>   |
| A <sub>16</sub> 20    | 35 🗖 A <sub>13</sub>   |
| A <sub>15</sub> 21    | 34 🗖 A <sub>14</sub>   |
| I/O <sub>0</sub> 22   | 33 I/O <sub>7</sub>    |
| V <sub>CC</sub> 23    | 32 🗖 V <sub>SS</sub>   |
| I/O <sub>1</sub> 24   | 31 🔲 I/O <sub>6</sub>  |
| I/O <sub>2</sub> □25  | 30 🗌 I/O <sub>5</sub>  |
| V <sub>SS</sub> 🗖 26  | 29 🗆 V <sub>CC</sub>   |
| I/O <sub>3</sub> 27   | 28 🗌 I/O <sub>4</sub>  |
|                       |                        |

Notes

3. NC pins are not connected on the die.

4. In BV1XI package, ball A6 is NC, ball H6 is NC and ball G2 is MSB address A19. BV1XI package has only single Chip Enable (CE).



### **Maximum Ratings**

Exceeding maximum ratings may impair the useful life of the device. These user guidelines are not tested.

| Storage Temperature65 °C to +150 °C   |  |
|---|--|
| Ambient Temperature<br>with Power Applied   |  |
| Supply Voltage on $V_{CC}$ relative to GND $^{[5]}$ –0.5 V to +4.6 V              |  |
| DC Voltage Applied to Outputs in High Z State $^{[5]}$ –0.5 V to $V_{CC}$ + 0.5 V |  |

| DC Input Voltage <sup>[5]</sup>                        | –0.5 V to $V_{CC}$ + 0.5 V |
|--|----------------------------|
| Current into Outputs (LOW)                             |                            |
| Static Discharge Voltage<br>(MIL-STD-883, Method 3015) | >2001 V                    |
| Latch Up Current                                       | >200 mA                    |

## **Operating Range**

| Range      | Ambient Temperature | V <sub>cc</sub> |
|------------|---------------------|-----------------|
| Industrial | –40 °C to +85 °C    | $3.3~V\pm0.3~V$ |

## **DC Electrical Characteristics**

Over the Operating Range

| Parameter        | Departmention                                    | Test Conditions  | -10  | -10                   |      |
|------------------|--|--|------|-----------------------|------|
| Parameter        | Description                                      |  | Min  | Max                   | Unit |
| V <sub>OH</sub>  | Output HIGH voltage                              | $V_{CC}$ = Min, $I_{OH}$ = -4.0 mA   | 2.4  | -                     | V    |
| V <sub>OL</sub>  | Output LOW voltage                               | $V_{CC}$ = Min, I <sub>OL</sub> = 8.0 mA   | -    | 0.4                   | V    |
| V <sub>IH</sub>  | Input HIGH voltage                               | -  | 2.0  | V <sub>CC</sub> + 0.3 | V    |
| V <sub>IL</sub>  | Input LOW voltage [5]                            | -  | -0.3 | 0.8                   | V    |
| I <sub>IX</sub>  | Input leakage current                            | $GND \leq V_I \leq V_{CC}$   | -1   | +1                    | μA   |
| I <sub>OZ</sub>  | Output leakage current                           | $GND \leq V_{OUT} \leq V_{CC}$ , Output disabled   | -1   | +1                    | μA   |
| I <sub>CC</sub>  | V <sub>CC</sub> operating supply current         | V <sub>CC</sub> = Max, f = f <sub>MAX</sub> = 1/t <sub>RC,</sub> I <sub>OUT</sub> = 0 mA,<br>CMOS levels   | -    | 175                   | mA   |
| I <sub>SB1</sub> | Automatic CE power down<br>current – TTL inputs  | $\begin{array}{l} Max \ V_{CC}, \ \overline{CE}_1 \geq V_{IH}, \ CE_2 \leq V_{IL}, \\ V_{IN} \geq V_{IH} \ \text{or} \ V_{IN} \leq V_{IL}, \ f = f_{MAX} \end{array}$  | -    | 30                    | mA   |
| I <sub>SB2</sub> | Automatic CE power down<br>current – CMOS inputs | $ \begin{array}{l} \mbox{Max } V_{CC}, \ \overline{CE}_1 \geq V_{CC} - 0.3 \ \mbox{V}, \ CE_2 \leq 0.3 \ \mbox{V}, \\ V_{IN} \geq V_{CC} - 0.3 \ \mbox{V}, \ \mbox{or } V_{IN} \leq 0.3 \ \mbox{V}, \ \mbox{f} = 0 \end{array} $ | -    | 25                    | mA   |



### Capacitance

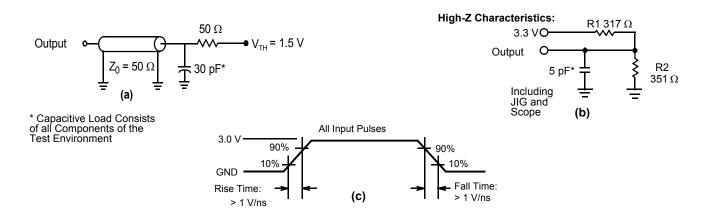
| Parameter [6]    | Description       | Test Conditions  | 54-pin TSOP II | 48-ball VFBGA | Unit |
|------------------|-------------------|--|----------------|---------------|------|
| C <sub>IN</sub>  | Input capacitance | T <sub>A</sub> = 25 °C, f = 1 MHz, V <sub>CC</sub> = 3.3 V | 6              | 8             | pF   |
| C <sub>OUT</sub> | I/O capacitance   |  | 8              | 10            | pF   |

#### **Thermal Resistance**

| Parameter [6]   | Description                              | Test Conditions   | 54-pin TSOP II | 48-ball VFBGA | Unit |
|-----------------|--|---|----------------|---------------|------|
| $\Theta_{JA}$   |  | Still air, soldered on a 3 × 4.5 inch, four-layer printed circuit board | 76.15          | 28.37         | °C/W |
| Θ <sub>JC</sub> | Thermal resistance<br>(junction to case) |   | 14.15          | 5.79          | °C/W |

#### **AC Test Loads and Waveforms**

Figure 5. AC Test Loads and Waveforms [7]



#### Notes

- 6. Tested initially and after any design or process changes that may affect these parameters.
   7. Valid SRAM operation does not occur until the power supplies have reached the minimum operating V<sub>DD</sub> (3.0 V). 100 μs (t<sub>power</sub>) after reaching the minimum operating V<sub>DD</sub>, normal SRAM operation begins including reduction in V<sub>DD</sub> to the data retention (V<sub>CCDR</sub>, 2.0 V) voltage.



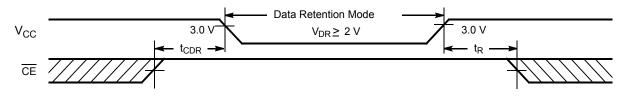
### **Data Retention Characteristics**

#### Over the Operating Range

| Parameter                       | Description                          | Conditions  | Min             | Мах | Unit |
|---------------------------------|--------------------------------------|---|-----------------|-----|------|
| V <sub>DR</sub>                 | V <sub>CC</sub> for data retention   | _   | 2               | -   | V    |
| I <sub>CCDR</sub>               | Data retention current               | $V_{CC} = 2 \text{ V}, \overline{CE}_1 \ge V_{CC} - 0.2 \text{ V}, CE_2 \le 0.2 \text{ V}, \\ V_{IN} \ge V_{CC} - 0.2 \text{ V} \text{ or } V_{IN} \le 0.2 \text{ V}$ | _               | 25  | mA   |
| t <sub>CDR</sub> <sup>[8]</sup> | Chip deselect to data retention time | -   | 0               | -   | ns   |
| t <sub>R</sub> [9]              | Operation recovery time              | _   | t <sub>RC</sub> | I   | ns   |

#### **Data Retention Waveform**

Figure 6. Data Retention Waveform <sup>[10]</sup>



#### Notes

Notes
 Tested initially and after any design or process changes that may affect these parameters.
 Full device operation requires linear V<sub>CC</sub> ramp from V<sub>DR</sub> to V<sub>CC(min.)</sub> ≥ 50 μs or stable at V<sub>CC(min.)</sub> ≥ 50 μs.
 Eor all packages except -BV1XI, CE is the logical combination of CE<sub>1</sub> and CE<sub>2</sub>. When CE<sub>1</sub> is LOW and CE<sub>2</sub> is HIGH, CE is LOW; when CE<sub>1</sub> is HIGH or CE<sub>2</sub> is LOW, CE is HIGH. For -BV1XI package, CE refers to CE.



### **AC Switching Characteristics**

Over the Operating Range

| Parameter [11]     | Description  | -   | -10 |      |
|--------------------|--|-----|-----|------|
| Parameter          | Description  |     | Мах | Unit |
| Read Cycle         |  | ·   |     |      |
| t <sub>power</sub> | V <sub>CC</sub> (typical) to the first access <sup>[12]</sup>          | 100 | -   | μS   |
| t <sub>RC</sub>    | Read cycle time  | 10  | -   | ns   |
| t <sub>AA</sub>    | Address to data valid  | -   | 10  | ns   |
| t <sub>OHA</sub>   | Data hold from address change  | 3   | -   | ns   |
| t <sub>ACE</sub>   | CE <sub>1</sub> LOW/CE <sub>2</sub> HIGH to data valid                 | -   | 10  | ns   |
| t <sub>DOE</sub>   | OE LOW to data valid   | -   | 5   | ns   |
| t <sub>LZOE</sub>  | OE LOW to low Z <sup>[13]</sup>  | 1   | -   | ns   |
| t <sub>HZOE</sub>  | OE HIGH to high Z <sup>[13]</sup>                                      | -   | 5   | ns   |
| t <sub>LZCE</sub>  | CE <sub>1</sub> LOW/CE <sub>2</sub> HIGH to low Z <sup>[13]</sup>      | 3   | -   | ns   |
| t <sub>HZCE</sub>  | CE <sub>1</sub> HIGH/CE <sub>2</sub> LOW to high Z <sup>[13]</sup>     | -   | 5   | ns   |
| t <sub>PU</sub>    | CE <sub>1</sub> LOW/CE <sub>2</sub> HIGH to power-up <sup>[14]</sup>   | 0   | -   | ns   |
| t <sub>PD</sub>    | CE <sub>1</sub> HIGH/CE <sub>2</sub> LOW to power-down <sup>[14]</sup> | -   | 10  | ns   |
| t <sub>DBE</sub>   | Byte enable to data valid  | -   | 5   | ns   |
| t <sub>LZBE</sub>  | Byte enable to low Z   | 1   | -   | ns   |
| t <sub>HZBE</sub>  | Byte disable to high Z   | -   | 5   | ns   |
| Write Cycle [15    | , 16]  | ·   |     |      |
| t <sub>WC</sub>    | Write cycle time   | 10  | -   | ns   |
| t <sub>SCE</sub>   | CE <sub>1</sub> LOW/CE <sub>2</sub> HIGH to write end                  | 7   | -   | ns   |
| t <sub>AW</sub>    | Address setup to write end   | 7   | _   | ns   |
| t <sub>HA</sub>    | Address hold from write end  | 0   | -   | ns   |
| t <sub>SA</sub>    | Address setup to write start   | 0   | -   | ns   |
| t <sub>PWE</sub>   | WE pulse width   | 7   | -   | ns   |
| t <sub>SD</sub>    | Data setup to write end  | 5.5 | -   | ns   |
| t <sub>HD</sub>    | Data hold from write end   | 0   | _   | ns   |
| t <sub>LZWE</sub>  | WE HIGH to low Z <sup>[13]</sup>                                       | 3   | -   | ns   |
| t <sub>HZWE</sub>  | WE LOW to high Z <sup>[13]</sup>                                       | _   | 5   | ns   |
| t <sub>BW</sub>    | Byte Enable to End of Write  | 7   | -   | ns   |

Notes

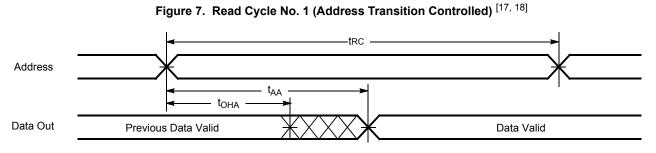
14. These parameters are guaranteed by design and are not tested. 15. The internal write time of the memory is defined by the overlap of  $\overline{WE}$ ,  $\overline{CE}_1 = V_{IL}$ , and  $CE_2 = V_{IH}$ . Chip enables must be active and  $\overline{WE}$  and byte enables must be LOW to initiate a write, and the transition of any of these signals can terminate. The input data setup and hold timing should be referenced to the edge of the signal that terminates the write.

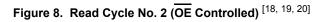
16. The minimum write cycle time for Write Cycle No. 2 (WE Controlled,  $\overline{OE}$  LOW) is the sum of t<sub>HZWE</sub> and t<sub>SD</sub>.

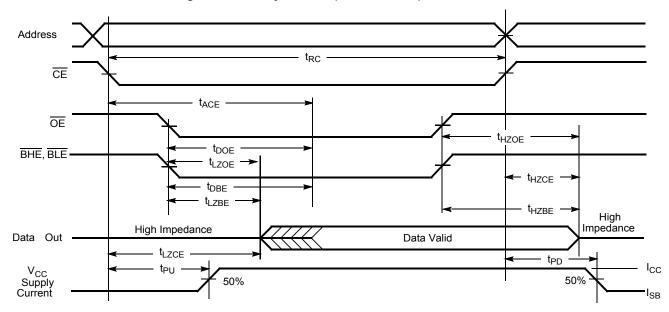
<sup>11.</sup> Test conditions assume signal transition time of 3 ns or less, timing reference levels of 1.5 V, and input pulse levels of 0 to 3.0 V. Test conditions for the read cycle use output loading shown in part (a) of Figure 5 on page 6, unless specified otherwise.
12. t<sub>POWER</sub> gives the minimum amount of time that the power supply is at typical V<sub>CC</sub> values until the first memory access is performed.
13. t<sub>HZOE</sub>, t<sub>HZCE</sub>, t<sub>HZWE</sub>, t<sub>HZBE</sub>, t<sub>LZCE</sub>, t<sub>L</sub>



#### **Switching Waveforms**







Notes

17. <u>The</u> device is continuously selected.  $\overline{OE}$ ,  $\overline{CE} = V_{IL}$ ,  $\overline{BHE}$ ,  $\overline{BLE}$  or both =  $V_{IL}$ .

18. WE is HIGH for read cycle.

19. For all packages except -BV1XI,  $\overline{CE}$  is the logical combination of  $\overline{CE}_1$  and  $CE_2$ . When  $\overline{CE}_1$  is LOW and  $CE_2$  is HIGH,  $\overline{CE}$  is LOW; when  $\overline{CE}_1$  is HIGH or  $CE_2$  is LOW,  $\overline{CE}$  is HIGH. For -BV1XI package,  $\underline{CE}$  refers to  $\overline{CE}_2$ . 20. Address valid before or similar to  $\overline{CE}$  transition LOW.



#### Switching Waveforms (continued)

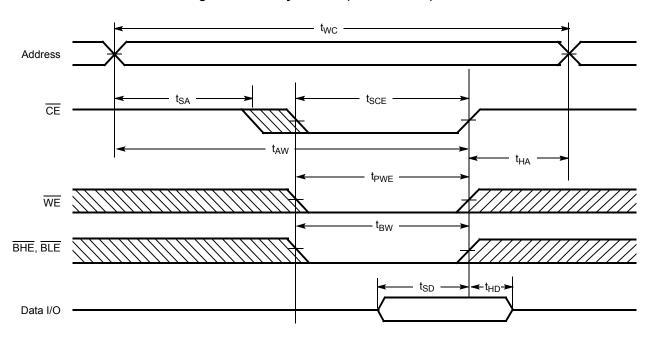
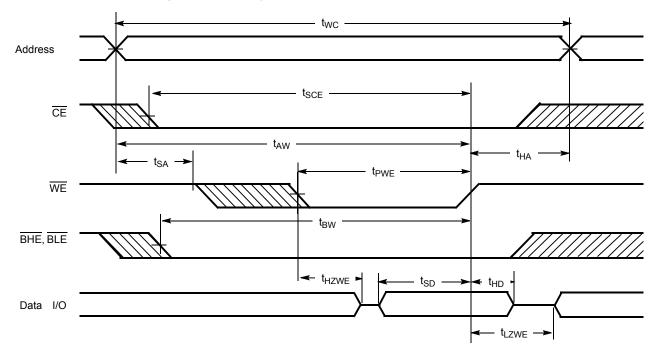


Figure 9. Write Cycle No. 1 (CE Controlled) <sup>[21, 22, 23]</sup>

## Figure 10. Write Cycle No. 2 (WE Controlled, OE LOW) <sup>[21, 22, 23, 24]</sup>



#### Notes

- Notes

   21. Eor all packages except -BV1XI, CE is the logical combination of CE<sub>1</sub> and CE<sub>2</sub>. When CE<sub>1</sub> is LOW and CE<sub>2</sub> is HIGH, CE is LOW; when CE<sub>1</sub> is HIGH or CE<sub>2</sub> is LOW, CE is HIGH. For -BV1XI package, CE refers to CE.

   22. Data I/O is high impedance if OE, BHE, and/or BLE = V<sub>IH</sub>.

   23. If CE goes HIGH simultaneously with WE going HIGH, the output remains in a high-impedance state.

   24. The minimum write cycle time is the sum of t<sub>HZWE</sub> and t<sub>SD</sub>.



#### Switching Waveforms (continued)

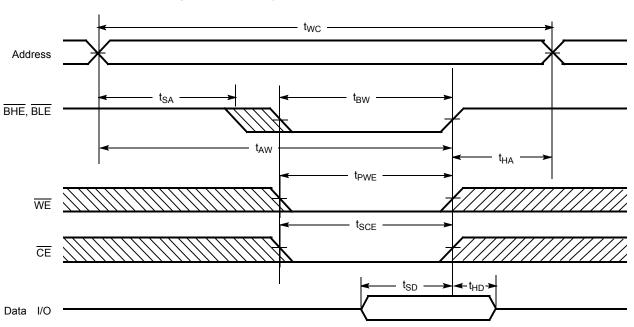
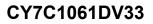


Figure 11. Write Cycle No. 3 (BLE or BHE Controlled) <sup>[25]</sup>

Note

25. For all packages except -BV1XI, CE is the logical combination of CE<sub>1</sub> and CE<sub>2</sub>. When CE<sub>1</sub> is LOW and CE<sub>2</sub> is HIGH, CE is LOW; when CE<sub>1</sub> is HIGH or CE<sub>2</sub> is LOW, CE is HIGH. For -BV1XI package, CE refers to CE.





### **Truth Table**

For all packages except -BV1XI

| CE <sub>1</sub> | CE <sub>2</sub> | OE | WE | BLE | BHE | I/O <sub>0</sub> -I/O <sub>7</sub> | I/O <sub>8</sub> -I/O <sub>15</sub> | Mode                       | Power                      |
|-----------------|-----------------|----|----|-----|-----|------------------------------------|-------------------------------------|----------------------------|----------------------------|
| Н               | Х               | Х  | Х  | Х   | Х   | High Z                             | High Z                              | Power down                 | Standby (I <sub>SB</sub> ) |
| Х               | L               | Х  | Х  | Х   | Х   | High Z                             | High Z                              | Power down                 | Standby (I <sub>SB</sub> ) |
| L               | Н               | L  | Н  | L   | L   | Data out                           | Data out                            | Read all bits              | Active (I <sub>CC</sub> )  |
| L               | Н               | L  | Н  | L   | Н   | Data out                           | High Z                              | Read lower bits only       | Active (I <sub>CC</sub> )  |
| L               | Н               | L  | Н  | Н   | L   | High Z                             | Data out                            | Read upper bits only       | Active (I <sub>CC</sub> )  |
| L               | Н               | Х  | L  | L   | L   | Data in                            | Data in                             | Write all bits             | Active (I <sub>CC</sub> )  |
| L               | Н               | Х  | L  | L   | Н   | Data in                            | High Z                              | Write lower bits only      | Active (I <sub>CC</sub> )  |
| L               | Н               | Х  | L  | Н   | L   | High Z                             | Data in                             | Write upper bits only      | Active (I <sub>CC</sub> )  |
| L               | Н               | Н  | Н  | Х   | Х   | High Z                             | High Z                              | Selected, outputs disabled | Active (I <sub>CC</sub> )  |

## Truth Table

For -BV1XI package only

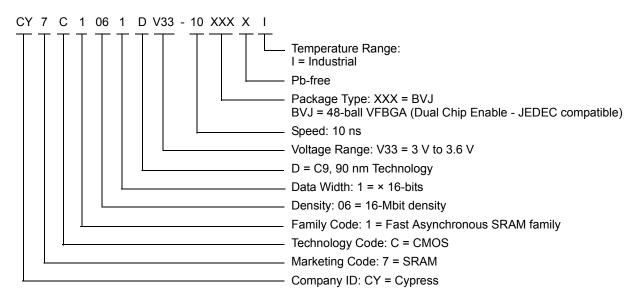
| CE | OE | WE | BLE | BHE | 1/0 <sub>0</sub> -1/0 <sub>7</sub> | I/O <sub>8</sub> –I/O <sub>15</sub> | Mode                       | Power                      |
|----|----|----|-----|-----|------------------------------------|-------------------------------------|----------------------------|----------------------------|
| Н  | Х  | Х  | Х   | Х   | High Z                             | High Z                              | Power down                 | Standby (I <sub>SB</sub> ) |
| L  | L  | Н  | L   | L   | Data out                           | Data out                            | Read all bits              | Active (I <sub>CC</sub> )  |
| L  | L  | Н  | L   | Н   | Data out                           | High Z                              | Read lower bits only       | Active (I <sub>CC</sub> )  |
| L  | L  | Н  | Н   | L   | High Z                             | Data out                            | Read upper bits only       | Active (I <sub>CC</sub> )  |
| L  | Х  | L  | L   | L   | Data in                            | Data in                             | Write all bits             | Active (I <sub>CC</sub> )  |
| L  | Х  | L  | L   | Н   | Data in                            | High Z                              | Write lower bits only      | Active (I <sub>CC</sub> )  |
| L  | Х  | L  | Н   | L   | High Z                             | Data in                             | Write upper bits only      | Active (I <sub>CC</sub> )  |
| L  | Н  | Н  | Х   | Х   | High Z                             | High Z                              | Selected, outputs disabled | Active (I <sub>CC</sub> )  |



### **Ordering Information**

| Speed<br>(ns) | Ordering Code        | Package<br>Diagram | Package Type  | Operating<br>Range |
|---------------|----------------------|--------------------|---|--------------------|
| 10            | CY7C1061DV33-10BVJXI |                    | 48-ball VFBGA (8 × 9.5 × 1 mm) (Pb-free) (Dual Chip Enable -<br>JEDEC compatible) | Industrial         |

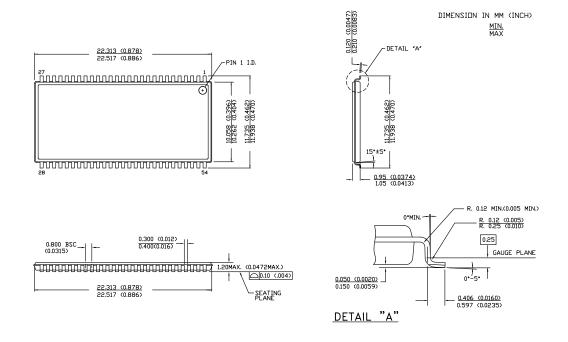
#### **Ordering Code Definitions**





### **Package Diagrams**

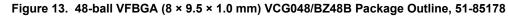
Figure 12. 54-pin TSOP II (22.4 × 11.84 × 1.0 mm) Z54-II Package Outline, 51-85160

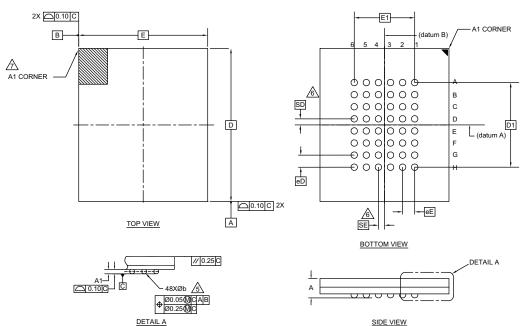


51-85160 \*E



#### Package Diagrams (continued)





SIDE VIEW

|        |          | DIMENSIONS |      |  |  |  |
|--------|----------|------------|------|--|--|--|
| SYMBOL | MIN.     | NOM.       | MAX. |  |  |  |
| А      | -        | -          | 1.00 |  |  |  |
| A1     | 0.16     | 0.21       | 0.26 |  |  |  |
| D      |          | 9.50 BSC   |      |  |  |  |
| E      |          | 8.00 BSC   |      |  |  |  |
| D1     | 5.25 BSC |            |      |  |  |  |
| E1     |          | 3.75 BSC   |      |  |  |  |
| MD     | 8        |            |      |  |  |  |
| ME     |          |            |      |  |  |  |
| N      |          | 48         |      |  |  |  |
| Øb     | 0.25     | 0.30       | 0.35 |  |  |  |
| eD     | 0.75 BSC |            |      |  |  |  |
| eE     | 0.75 BSC |            |      |  |  |  |
| SD     | 0.38     |            |      |  |  |  |
| SE     | 0.38     |            |      |  |  |  |

- NOTES 1. ALL DIMENSIONS ARE IN MILLIMETERS.
- 2. SOLDER BALL POSITION DESIGNATION PER JEP95, SECTION 3, SPP-020.
- 3. "e" REPRESENTS THE SOLDER BALL GRID PITCH.
- 4. SYMBOL "MD" IS THE BALL MATRIX SIZE IN THE "D" DIRECTION. SYMBOL "ME" IS THE BALL MATRIX SIZE IN THE "E" DIRECTION. N IS THE NUMBER OF POPULATED SOLDER BALL POSITIONS FOR MATRIX SIZE MD X ME.
- 5. DIMENSION "b" IS MEASURED AT THE MAXIMUM BALL DIAMETER IN A PLANE PARALLEL TO DATUM C.
- 6. "SD" AND "SE" ARE MEASURED WITH RESPECT TO DATUMS A AND B AND DEFINE THE POSITION OF THE CENTER SOLDER BALL IN THE OUTER ROW. WHEN THERE IS AN ODD NUMBER OF SOLDER BALLS IN THE OUTER ROW, "SD" OR "SE" = 0.
  - WHEN THERE IS AN EVEN NUMBER OF SOLDER BALLS IN THE OUTER ROW, "SD" = eD/2 AND "SE" = eE/2.
- A1 CORNER TO BE IDENTIFIED BY CHAMFER, LASER OR INK MARK METALIZED MARK, INDENTATION OR OTHER MEANS.
- 8. "+" INDICATES THE THEORETICAL CENTER OF DEPOPULATED SOLDER BALLS.

51-85178 \*D





## Acronyms

| Acronym | Description                             |
|---------|---|
| BHE     | Byte High Enable                        |
| BLE     | Byte Low Enable                         |
| CE      | Chip Enable                             |
| CMOS    | Complementary Metal Oxide Semiconductor |
| I/O     | Input/Output                            |
| OE      | Output Enable                           |
| SRAM    | Static Random Access Memory             |
| TSOP    | Thin Small Outline Package              |
| TTL     | Transistor-Transistor Logic             |
| VFBGA   | Very Fine-Pitch Ball Grid Array         |
| WE      | Write Enable                            |

### **Document Conventions**

#### **Units of Measure**

| Symbol | Unit of Measure |
|--------|-----------------|
| °C     | degree Celsius  |
| MHz    | megahertz       |
| μA     | microampere     |
| μS     | microsecond     |
| mA     | milliampere     |
| mm     | millimeter      |
| ns     | nanosecond      |
| Ω      | ohm             |
| %      | percent         |
| pF     | picofarad       |
| V      | volt            |
| W      | watt            |





## **Document History Page**

| Document Title: CY7C1061DV33, 16-Mbit (1M × 16) Static RAM |
|--|
| Document Number: 38-05476                                  |

| Rev. | ECN No. | Orig. of<br>Change | Submission<br>Date | Description of Change   |
|------|---------|--------------------|--------------------|---|
| **   | 201560  | SWI                | See ECN            | Advance data sheet for C9 IPP   |
| *A   | 233748  | RKF                | See ECN            | Updated AC and DC parameters as per EROS (Specification Number 01-02165).<br>Updated Ordering Information (Added Pb-free devices).  |
| *В   | 469420  | NXR                | See ECN            | Changed status from Advance Information to Preliminary.<br>Updated Document Title (Corrected typo).<br>Removed 8 ns and 12 ns speed bins related information in all instances across<br>the document.<br>Removed Commercial Temperature Range related information in all instances<br>across the document.<br>Updated Selection Guide:<br>Changed value of "Maximum Operating Current" corresponding to 10 ns speed<br>bin from 176 mA to 125 mA.<br>Changed value of "Maximum CMOS Standby Current" corresponding to 10 ns<br>speed bin from 40 mA to 25 mA.<br>Updated Pin Configurations:<br>Changed ball 2G of FBGA and pin 40 of TSOP II from DNU to NC.<br>Updated Maximum Ratings:<br>Included details corresponding to "Static Discharge Voltage" and "Latch-Up<br>Current".<br>Updated DC Electrical Characteristics:<br>Updated DC Electrical Characteristics:<br>Updated Note 5 (Specified the Overshoot specification).<br>Changed maximum value of I <sub>CC</sub> parameter corresponding to 10 ns speed bin<br>from 176 mA to 30 mA.<br>Changed maximum value of I <sub>SB1</sub> parameter corresponding to 10 ns speed bin<br>from 40 mA to 30 mA.<br>Changed maximum value of I <sub>SB2</sub> parameter corresponding to 10 ns speed bin<br>from 40 mA to 25 mA. |
| *C   | 499604  | NXR                | See ECN            | Updated Pin Configurations:<br>Added Note 1 and referred the same note in Pin Configurations.<br>Updated DC Electrical Characteristics:<br>Updated details in "Test Condition" column corresponding to I <sub>CC</sub> parameter.<br>Updated Package Diagrams:<br>Updated figure corresponding to 48-ball FBGA Package (Removed spec<br>51-85150 *D and added spec 51-85178 **).  |
| *D   | 1462583 | VKN /<br>AESA      | See ECN            | Changed status from Preliminary to Final.<br>Updated Selection Guide:<br>Changed value of "Maximum Operating Current" from 125 mA to 175 mA<br>corresponding to 10 ns speed bin.<br>Updated DC Electrical Characteristics:<br>Changed maximum value of I <sub>CC</sub> parameter from 125 mA to 175 mA<br>corresponding to 10 ns speed bin.<br>Updated Thermal Resistance:<br>Replaced TBD with values for all packages.  |
| *E   | 2704415 | VKN /<br>PYRS      | 05/11/09           | Included 48-ball FBGA Dual Chip Enable - JEDEC compatible package related information in all instances across the document.<br>Updated Pin Configurations:<br>Added Note 2 and referred the same note in Figure 1 and Figure 2.   |
| *F   | 3109102 | AJU                | 12/13/2010         | Added Ordering Code Definitions under Ordering Information.<br>Updated Package Diagrams.  |



## Document History Page (continued)

|      | ocument Title: CY7C1061DV33, 16-Mbit (1M × 16) Static RAM<br>ocument Number: 38-05476 |                    |                    |   |  |  |  |
|------|---|--------------------|--------------------|---|--|--|--|
| Rev. | ECN No.   | Orig. of<br>Change | Submission<br>Date | Description of Change   |  |  |  |
| *G   | 3126531   | PRAS               | 01/03/2011         | Added 48-ball VFBGA Single Chip Enable package related information in all instances across the document.<br>Updated Ordering Information.<br>Added Acronyms.  |  |  |  |
| *H   | 3414708   | TAVA               | 10/19/2011         | Updated Features.<br>Updated DC Electrical Characteristics.<br>Updated Switching Waveforms.<br>Updated Package Diagrams.<br>Added Units of Measure.<br>Updated to new template.   |  |  |  |
| *    | 4574311   | TAVA               | 11/19/2014         | Updated Functional Description:<br>Added "For a complete list of related documentation, click here." at the end.<br>Updated Package Diagrams:<br>spec 51-85160 – Changed revision from *C to *E.<br>spec 51-85178 – Changed revision from *A to *C.   |  |  |  |
| ۲,   | 4990813   | NILE               | 10/27/2015         | Updated Thermal Resistance:<br>Changed value of $\Theta_{JA}$ parameter corresponding to 54-pin TSOP II package<br>from 24.18 °C/W to 76.15 °C/W.<br>Changed value of $\Theta_{JC}$ parameter corresponding to 54-pin TSOP II package<br>from 5.40 °C/W to 14.15 °C/W.<br>Updated Switching Waveforms:<br>Added Note 24 and referred the same note in Figure 10.<br>Updated to new template.<br>Completing Sunset Review. |  |  |  |
| *К   | 5529600   | VINI               | 11/22/2016         | Updated Ordering Information:<br>Updated part numbers.<br>Updated Package Diagrams:<br>spec 51-85178 – Changed revision from *C to *D.<br>Updated to new template.<br>Completing Sunset Review.   |  |  |  |



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